

RoHS COMPLIANT

Vishay Siliconix

P-Channel 30-V (D-S) MOSFET

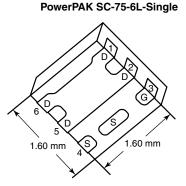
PRODUCT SUMMARY					
V _{DS} (V)	R _{DS(on)} (Ω)	I _D (A) ^{a, f}	Q _g (Typ.)		
- 30	0.087 at V _{GS} = - 10 V	- 9	3.5 nC		
- 30	0.158 at V _{GS} = - 4.5 V	- 7.2	0.5110		

FEATURES

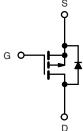
- · Halogen-free
- TrenchFET[®] Power MOSFET
- New Thermally Enhanced PowerPAK® SC-75 Package
 - Small Footprint Area

APPLICATIONS

Load Switch, PA Switch and Battery Switch for Portable Devices



Ma	arking Co	ode
Part # code -	BDX	
Fait # code —	• <u>x x x</u>	Lot Traceability and Date code



P-Channel MOSFET

Ordering Information: SiB415DK-T1-GE3 (Lead (Pb)-free and Halogen-free)

Parameter		Symbol	Limit	Unit	
Drain-Source Voltage		V _{DS}	- 30	V	
Gate-Source Voltage		V _{GS}	± 20	v	
	T _C = 25 °C T _C = 70 °C		- 9 ^a - 7.7	-	
Continuous Drain Current (T _J = 150 °C)	T _A = 25 °C T _A = 70 °C	I _D	- 4.17 ^{a, b} - 3.36 ^{a, b}	A	
Pulsed Drain Current		I _{DM}	15	_	
Continuous Source-Drain Diode Current	T _C = 25 °C T _A = 25 °C	I _S	- 9 ^a - 2 ^{a, b}	_	
Maximum Power Dissipation	$T_{C} = 25 °C$ $T_{C} = 70 °C$ $T_{A} = 25 °C$	P _D	13 8.4	w	
Operating Junction and Storage Temperature F	T _A = 70 °C	T _J , T _{stq}	2.4 ^{a, b} 1.6 ^{a, b} - 55 to 150		
Operating Junction and Storage Temperature Range Soldering Recommendations (Peak Temperature) ^{c, d}		'J' 'stg	260		

THERMAL RESISTANCE RATINGS						
Parameter		Symbol	Typical	Maximum	Unit	
Maximum Junction-to-Ambient ^{a, e}	t ≤ 5 s	R _{thJA}	41	51	°C/W	
Maximum Junction-to-Case (Drain)	Steady State	R _{thJC}	7.5	9.5	C/w	

Notes:

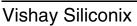
a. Surface Mounted on 1" x 1" FR4 board.

b. t = 5 s.

- c. See Solder Profile (http://www.vishay.com/ppg?73257). The PowerPAK SC-75 is a leadless package. The end of the lead terminal is exposed copper (not plated) as a result of the singulation process in manufacturing. A solder fillet at the exposed copper tip cannot be guaranteed and is not required to ensure adequate bottom side solder interconnection.
- d. Rework Conditions: manual soldering with a soldering iron is not recommended for leadless components.

e. Maximum under Steady State conditions is 105 °C/W.

f. Based on $T_C = 25$ °C.





SPECIFICATIONS T _J = 25 °C, Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Unit	
Static	Cymbol			Typ.	max.		
Drain-Source Breakdown Voltage	V _{DS}	V _{GS} = 0 V, I _D = - 250 μA	- 30			V	
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_J$			- 24.2			
V _{GS(th)} Temperature Coefficient	$\Delta V_{GS(th)}/T_J$	I _D = - 250 μA		4		mV/°C	
Gate-Source Threshold Voltage	V _{GS(th)}	V _{DS} = V _{GS} , I _D = - 250 μA	- 1		- 3	V	
Gate-Source Leakage	I _{GSS}	$V_{DS} = 0 V, V_{GS} = \pm 20 V$			± 100	nA	
-		V _{DS} = - 30 V, V _{GS} = 0 V			- 1	+	
Zero Gate Voltage Drain Current	I _{DSS}	$V_{DS} = -30 \text{ V}, \text{ V}_{GS} = 0 \text{ V}, \text{ T}_{J} = 55 \text{ °C}$			- 10	μΑ	
On-State Drain Current ^a	I _{D(on)}	$V_{DS} \le 5 V, V_{GS} = -10 V$	5			A	
Drain-Source On-State Resistance ^a		$V_{GS} = -10 \text{ V}, \text{ I}_{D} = -4.17 \text{ A}$		0.072	0.087	+	
	R _{DS(on)}	V _{GS} = - 4.5 V, I _D = - 3.1 A		0.130	0.158	Ω	
Forward Transconductance ^a	9 _{fs}	V _{DS} = - 15 V, I _D = - 4.17 A		5.5		S	
Dynamic ^b							
Input Capacitance	C _{iss}			295			
Output Capacitance	C _{oss}	V _{DS} = - 15 V, V _{GS} = 0 V, f = 1 MHz		70		pF	
Reverse Transfer Capacitance	C _{rss}			50			
Table Oaks Observe		V _{DS} = - 15 V, V _{GS} = - 10 V, I _D = - 4.17 A		6.7	10.05		
Total Gate Charge	Qg			3.5	5.25		
Gate-Source Charge	Q _{gs}	V _{DS} = - 15 V, V _{GS} = - 4.5 V, I _D = - 4.17 A		1			
Gate-Drain Charge	Q _{gd}			1.78			
Gate Resistance	Rg	f = 1 MHz		9.4		Ω	
Turn-On Delay Time	t _{d(on)}			43	64.5		
Rise Time	t _r	V_{DD} = - 15 V, R_L = 6.07 Ω		55	82	- ns	
Turn-Off Delay Time	t _{d(off)}	$I_{D} \cong$ - 2.47 A, V_{GEN} = - 4.5 V, R_{g} = 1 Ω		13	19.5		
Fall Time	t _f			10	15		
Turn-On Delay Time	t _{d(on)}			6	9		
Rise Time	t _r	V_{DD} = - 15 V, R_L = 3.6 Ω		8.5	12.75		
Turn-Off Delay Time	t _{d(off)}	$\text{I}_\text{D}\cong$ - 4.17 A, V_GEN = - 10 V, R_g = 1 Ω		14	21		
Fall Time	t _f			9	13.5		
Drain-Source Body Diode Characterist	ics						
Continuous Source-Drain Diode Current	۱ _S	T _C = 25 °C			- 9	۸	
Pulse Diode Forward Current	I _{SM}				15	A	
Body Diode Voltage	V _{SD}	I _S = - 3.2 A, V _{GS} = 0 V		- 0.8	- 1.2	V	
Body Diode Reverse Recovery Time	t _{rr}			14.63	22	ns	
Body Diode Reverse Recovery Charge	Q _{rr}	I _F = - 3.2 A, di/dt = 100 A/μs, T _{.I} = 25 °C		8	12	nC	
Reverse Recovery Fall Time	ta	$F = -3.2$ A, $u/u = 100$ A/ μ s, $T_{J} = 25$ °C		9.13			
Reverse Recovery Rise Time	t _b	1 1		5.5		ns	

Notes:

a. Pulse test; pulse width \leq 300 µs, duty cycle \leq 2 %.

b. Guaranteed by design, not subject to production testing.

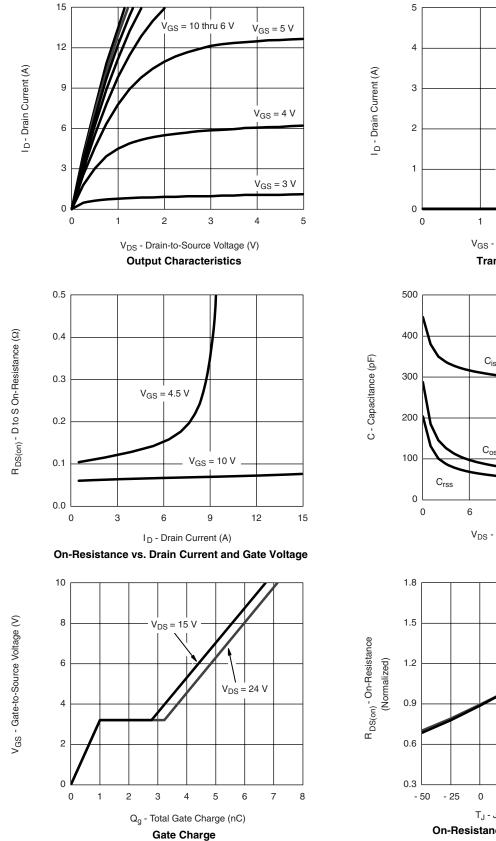
Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

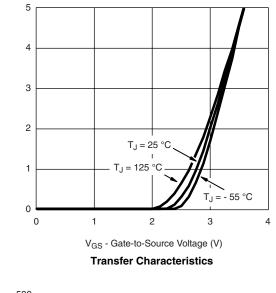


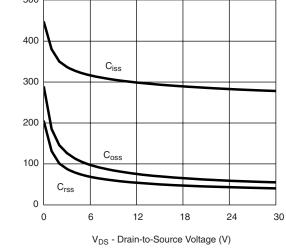


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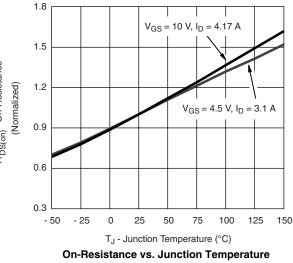
TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted







Capacitance

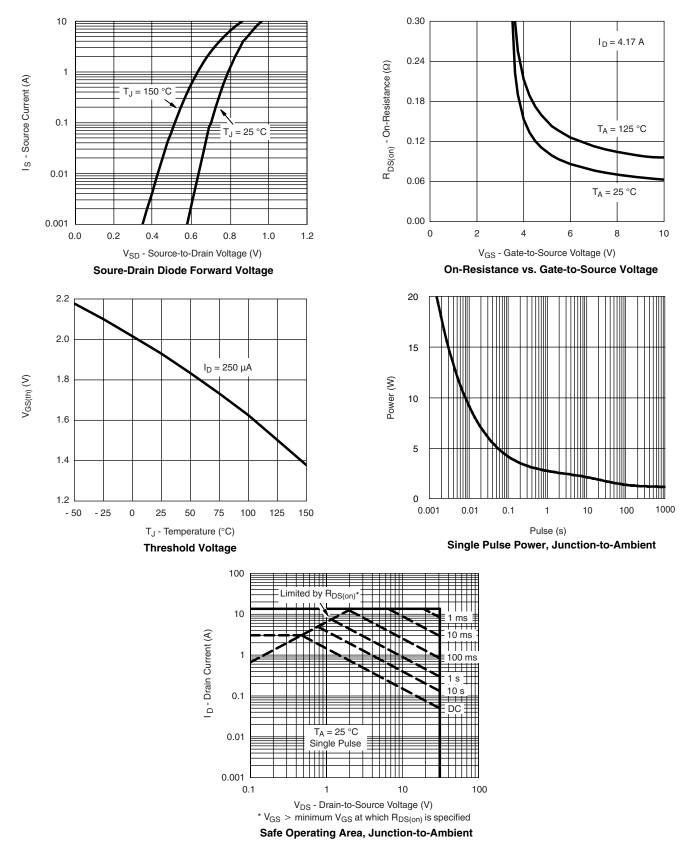


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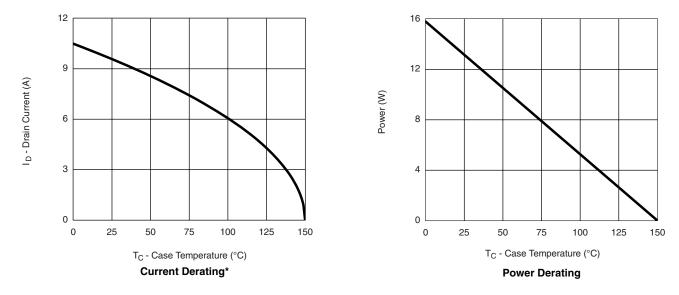






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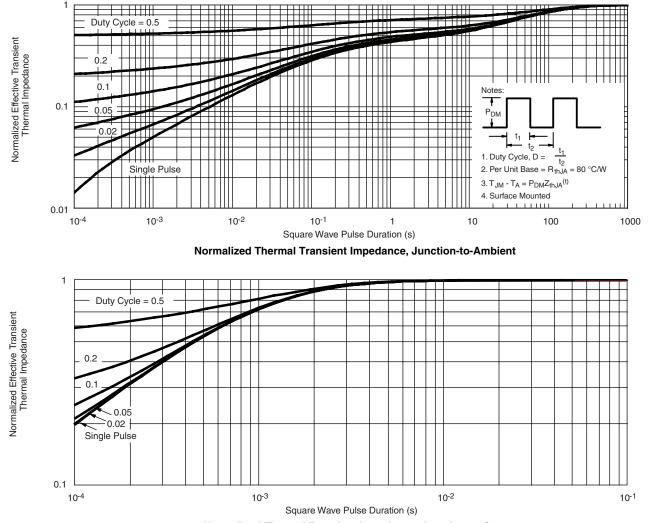


* The power dissipation P_D is based on $T_{J(max)}$ = 150 °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.

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TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted



Normalized Thermal Transient Impedance, Junction-to-Case

Vishay Siliconix maintains worldwide manufacturing capability. Products may be manufactured at one of several qualified locations. Reliability data for Silicon Technology and Package Reliability represent a composite of all qualified locations. For related documents such as package/tape drawings, part marking, and reliability data, see http://www.vishay.com/ppg?70438.



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